Test Probe INGUN E-Type

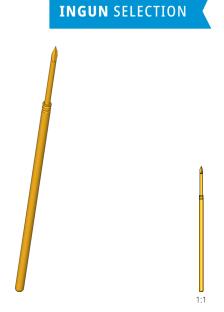
E-075 291 064 A 2800

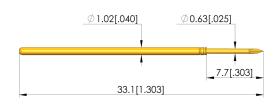
Item E-075-0002

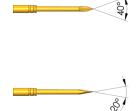




- Highest contact reliability under challenging test conditions without additional stress on the DUT: up to 25% larger contact surface between test probe and DUT
- When hitting the test surface a spring force up to 100% higher than a standard GKS is available, but the same spring force as a standard GKS is achieved at the working stroke.







General data

ICT / FCT (in-circuit test and function test Product group: Sub-product group: INGUN E-TYPE® E-075 Series: Grid: 1.91 mm [75.1 mil] Contacting from: Yes Plug-in

Magnetic: Installation type: Quick-exchange system: Adjustable installation height: Non-rotating: Compatible receptacle(s): KS-075 -40 °C [-40 °F] Min. temperature: Max. temperature: 80 °C [176 °F] RoHS-compliant:

Tip style data

Tip style: 91 dagger, self-cleaning Tip diameter: 0.64 mm [.025 in] Tip style surface: A gold Tip style material: 2 steel

Electrical data

Yes

No

No

Yes

Current load capacity / rated current: 3 A Typical resistance (Ri): 20 mOhm

Mechanical data

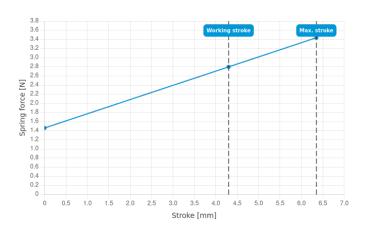
Total length: 33.1 mm [1.3 in] Barrel diameter: 1.02 mm [.04 in] Maximum stroke: 6.35 mm [.25 in] Spring pre-load: 1.46 N [5.25 ozf] Collar height: Spring force at working stroke: 2.8 N [10 ozf] Recommended working stroke: 4.3 mm [.169 in]

Partner for Future Technology

Test Probe INGUN E-Type E-075 291 064 A 2800

Item E-075-0002





INGUN Prüfmittelbau GmbH

Max-Stromeyer-Straße 162 78467, Constance, Germany Phone +49 7531 8105-0 Customer hotline +49 7531 8105-888 Fax +49 7531 8105-65 info@ingun.com









Learn more about **ICT/FCT Test probes**

